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Specification number:EQM08-1KC-E146K26

Date of issue: 16 June, 2014

Multilayer ceramic Chip capacitor specification

Product Part No

CM03X5R225M06AH

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Kyocera Corporation Capacitor Division



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1. Application

This specification is applied to the multilayer ceramic Chip capacitor supplied from KYOCERA.

2. Nomenclature

(Ex)	CM	<u>03</u>	<u>X5R</u>	<u>225</u>	M	<u>06</u>	<u>A</u>	<u>H</u>
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)

(0201size / X5R / 2,200,000pF \pm 20% / 6.3V $\,$)

- (1)Series CM Series
- (2)Size
- (3)Temperature Characteristics
- (4)Nominal capacitance
- (5)Tolerance
- (6)Voltage

(7)Termination A:Nickel barrier / Tin

(8)Packaging type



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3. Structure

(1) Size



Fig.1 Dimension

(2) Appearance

No problem is observed under a microscope.

(3) Internal structure







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4. Electrical properties

No	Item	Test Con	ditions	Specifications		
1	Temperature characteristic of capacitance	Keep the sample at 150+0/- the sample at room ambient Frequency Voltage Temperature range Reference temperature	10 °C for 1 hour, leave for 24±2 hours. 1kHz±10% 0.1+0.1/-0Vrms -55°C to 85°C 25°C	No applied voltage	Change in capacitance: Within ±15%	
2	Nominal capacitance and Tolerance	Keep the sample at 150+0/- the sample at room ambient Frequency Voltage	10 °C for 1 hour, leave for 24±2 hours. 1kHz±10% 1.0±0.2Vrms	e Within 2,200,000 pF ± 20%		
3	Dissipation factor (tanō)	Keep the sample at 150+0/- the sample at room ambient Frequency Voltage	10 °C for 1 hour, leave for 24±2 hours. 1kHz±10% 1.0±0.2Vrms	Within 12.5%		
4	Rated voltage	-		6.3V		
5	Insulation- resistance	Measure after 6.3V is applied room ambient. Charge and discharge current is	for 1 minute at 50mA or less.	5MΩ or over		
6	Dielectric Resistance	15.75 V(2.5 times of rated volt1 to 5seconds.Charge and discharge current i	age) is applied for s 50mA or less.	Dielectric brea	kdown should not occur.	



5. Reliability

No	Item	Test Conditions		Specifications		
		Keep the sample at 150+0/- 10 °C for 1 hour, leave sample at room ambient for 24±2 hours. Measure the initial capacitance and dissipation fact	the Appearance	No problem observed		
		Stage Temperature Time 1 Room temperature 3min 2 Lowest operation temperature 30min	Capacitance Change	Within ±15.0% of the initial capacitance.		
1	Temperature cvcle	3 Room temperature 3min 4 Highest operation temperature 30min After 5 cycle, measure after 24±2 hours.	Dissipation Factor(tanδ)	Within 12.5%.		
		The charge and discharge current of the capacitor is exceed 50mA for IR and withstanding voltage measurement.	IR	5MΩ or over		
		0.92 Fig. 2. Substrate for temperature quele tec	.26 Dielectric Resistance	Dielectric breakdown should not occur.		
	Load humidity test	Apply the below mentioned test condition for then leave the sample at room ambient for 24 hours and measure the initial capacitance and dissination factor	1 hour, ±2 Appearance	No problem observed		
		After applying 6.3V for $500+12/-0$ hours in pre-condition at $40+2^{\circ}$ C, humidity 90% to 95%	Capacitance Change	Within ±12.5% of the initial capacitance		
2		allow parts to stabilize for 24 ± 2 hours, at roon temperature before measurement.	ם Dissipation Factor(tanō)	Within 25.0%		
		Charge and discharge current of the capaci not exceed 50mA for IR measurement.	or must	0.5MΩ or over		
		Substrate for test is referred to Fig.3.				



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No	Item	Test Conditions	Specifications			
	High- temperature with loading	Apply the below mentioned test condition for 1 hour, then leave the sample at room ambient for 24±2 hours and measure the initial capacitance and dissipation factor.	Appearance	No problem observed		
2		After applying 6.3V(1 times of rated voltage) for 1000+12/-0 hours in pre-condition at 85±2°C, allow parts to stabilize for 24±2 hours, at room temperature before	Capacitance Change	Within ±12.5%of the initial capacitance.		
3		Charge and discharge current of the capacitor must not exceed 50mA for IR measurement.	Dissipation Factor(tanδ)	Within 25.0%		
		Substrate for test is referred to Fig.3.	IR	$1M\Omega$ or over		



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6. Soldering Heat Resistance

No	Item	Test Conditions					Specifications		
	Soldering Heat Resistance	Keep the sample at 150+0/- 10 °C for 1 hour, leave the sample at room ambient for 24±2 hours. Measure the initial capacitance and dissipation factor.					Appearance	No problem observed	
		<	<pre-hea< td=""><td>ating conditions> Temperature</td><td>Time</td><td>]</td><td>Capacitance Change</td><td>Within ±7.5% of the initial capacitance</td></pre-hea<>	ating conditions> Temperature	Time]	Capacitance Change	Within ±7.5% of the initial capacitance	
1		2 150~200°C 2min 2 150~200°C 2min Soak the sample in 260±5 °C solder for 10±0.5 seconds and leave the sample at room ambien				ambient.	Dissipation Factor(tanδ)	Within 12.5%	
		and measure the electrical properties after 24 ±2 hours.			and measure the electrical properties fter 24 ±2 hours.		IR	5MΩ or over	
		IR and the charge-and-discharge current of electric strength measurement are 50mA or less.				Dielectric Resistance	Dielectric breakdown should not occur.		

7.Solderability

No	Item	Test Conditions	Specifications			
1	Solderability	Lead-free soldering (Sn-3.0Ag-0.5Cu) Soak the sample in 245±5 °C lead-free solder for 3±0.5 seconds. Eutectic solder Soak the sample in 235±5 °C eutectic solder for 2±0.5 seconds.	Appearance	Solder coverage: 90% min.		



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■For lead-free soldering Recommended temperature profile



- (1) Minimize soldering time
- (2) Ensure that the temperature difference does not exceed 150 °C.
- (3) MLCC can withstand the above reflow conditions up to 3 times.
- (4) Cool naturally after soldering.

•Flow profile

Flow is not applicable for chips with size CM03.

•Soldering iron profile



- (1) Ensure that the chip capacitor is preheated adequately.
- (2) Ensure that the temperature difference between a capacitor and the soldering iron shall not exceed 150 °C.
- (3) Cool naturally after soldering.
- (4) Avoid direct touching to capacitors.
- (5) Tip shape of soldering iron is dia.3.0mm max.
- (6) Wattage 80W max.



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8.Mechanical Strength

No	Item	Test Conditions	Specifications			
1	Termination Strength	Apply a sideward force of 2N to a PCB-mounted sample. Substrate material: Glass epoxy.	Appearance	No problem observed		
2	Keep the sample at 150+0/- 10 °C for 1 hour, leave the sample at room ambient for 24±2 hours. Measure the initial capacitance and dissipation factor. Vibration Test Vibration frequency :10 to 55 (Hz) Amplitude : 1.5mm Sweeping condition : 10 ->55->10Hz/1 minute In X, Y and Z direction : 2 hours each		Appearance Capacitance Change	No problem observed. Within ±20% of the initial capacitance		
		Total 6 hours Substrate for test is referred to Figure 3.	Dissipation Factor(tanδ)	Within 12.5%		



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9.Packaging material

(1) Plastic reel dimensions



Fig.7 Reel dimensions

(2) Carrier tape dimensions

Pitch=2.0±0.05mm (Packaging code:H) Paper carrier tape





(3) Maximum packaging quantity
Maximum packaging quantity : 15000 pieces / Φ 180mm reel



10.Packaging style

- 1. Taping
- (1) Taping packaging



Fig. 9 Taping packaging schema

There are no capacitors in the leader and the trailer portion in taping packaging (refer to Fig. 10). End of the tape is not fixed to the reel to be released from the hub.



Fig.10 Detail of leader and trailer



(2) Peeling strength of the top tape

The peeling strength when peeling off the top tape from the carrier tape by the method of the following figrue shall be 0.1 to 0.7 N. (Refer to Fig 11)

Peeling angle: 165 to 180 degrees to the carrier tape. Peeling speed: 300mm/min



Fig.11 Peeling of the top tape (cross sectional view)

(3) Others

When bent a carrier tape at 25mm in radius, there is neither lack of a capacitor nor breakage of a tape (refer to Fig. 12).

When a top tape is peeled off, glue of the top tape adheres to the top tape side. Capacitors should not be adhered to the top tape.



Fig.12 Carrier tape bending (cross sectional view)



11.Label and location

(1) Label location for reels

The label shall be placed on one side of a reel (refer to Fig. 13).



Fig. 13 Label location for reels

(2) Label location for packaging boxes



Fig. 14 Label location for packaging boxes

12.Production Site

Kagoshima Kokubu plant(1-1, Kokubu-yamashita-cho, Kirishima-shi, Kagoshima)Shanghai Kyocera electronics(No. 2077 New Jin Qiao Road Jin Qiao Pudong Shanghai 201206)



13.Precautions

Handling

1) Cracks may occur unless otherwise avoiding excessive stress to the capacitors by the load of an adsorption nozzle, and bending of a substrate at the time of mounting.

2) Please arrange the capacitor position where they don't have too much stress of board bending after mounting.

3) Please design that the form and size of the land pattern has suitable solder amount.

Otherwise cracks may occur. The recommended fillet height shall be 1/2 to 1/3 of the thickness of capacitors.

Circuit Design

 When AC voltage is superimposed on DC voltage, the zero-to-peak voltage shall not exceed the rated voltage. When the capacitor is to be employed in a circuit in which there is continuous application of a high frequency Voltage or a steep pulse voltage, even though it is within the rated voltage, please inquire to the manufacturer.
Please use the capacitor below the maximum temperature.

When using the capacitor in a self-heating AC circuit, please make sure the surface of the capacitor remains under the maximum temperature for usage. Also, please make certain temperature rises remain below 20 °C.

Resin coating

Please use the resin of low curing shrinkage type. (Otherwise cracks may occur).

Storage

1) When the components is stored in minimal packaging (a heat-sealed or chuck-type plastic bag), the bag should be kept closed. Once the bag has been opened, reseal it or store it in a desiccator.

2) Keep storage place temperature +5 to +40 °C, humidity 20 to 70% RH.

3) The storage atmosphere must be free of gas containing sulfur and chlorine. Also, avoid exposing the product to saline moisture. If the product is exposed to such atmospheres, the terminals will oxidize and solderability will be effected.

4) Precautions 1) to 3) apply to chip capacitors packaged in carrier tapes and bulk cases.

5) The solderability is assured for 12 months from our shipping date if the above storage precautions are followed.

Application Restriction

Please consult with us before using a capacitor in the equipment which requires a high degree reliability (medical equipment, aerospace applications, nuclear equipment.) Malfunctions in medical, space, nuclear power or other vital equipment may result in death or great social losses. Capacitors designed specially with high reliability are used for the equipment above.

Export regulation

When the applying products relate the strategic materials which are provided in Foreign Exchange and Foreign Trade Act and Foreign Trade Management Law, the export license based on these laws are required.

Disposal

Please dispose the capacitors according to the relating laws about the waste treatment and cleaning. Safety application guideline and detailed information of electrical properties are also provided in Kyocera home page:

URL: http://www.kyocera.co.jp/electronic

Notice:

This specification shall guarantee only monolithic capacitors. Please make sure the performance of capacitors after mounted on the assembled product.

Any failures occurred being used out of this specification shall not be quaranteed.

This specification shall be applied to the products purchased through the regular sales routes, such as the sale offices, the subsidiaries and the distributors, etc.).



1	14.Revision History							
No.	Date	Contents	APPD	CHKD	CHKD	PREPD		
1	2014/06/16	New issue						





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